Se	earci	arch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/706,991	BEM ET AL.
Examiner	Art Unit
Jacques Veillard	2165

	SEARCHED			
Class	Subclass	Date	Examiner	
707	1-7	8/12/2006	J.V	
707	10,100	8/12/2006	J.V	
707	101,104.1	8/12/2006	J.V	
709	218-219	8/12/2006	J.V	

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EIC Plus database searh	8/8/2006	J.V
consulted with L.Wassum primary AU 2167	8/10/2006	J.V
East electronic database search	8/12/2006	J.V
STIC Search Report prepared by EIC 2100 Staff	8/15/2006	J.V
Email 101 panel regarding 101 issue. Response from panel by W. Grant, claims 1-24, 40-41 are nonstatutory	8/22/2006	J.V